

STGB10NC60HD STGP10NC60HD

N-channel 600V - 10A - TO-220 - D²PAK Very fast PowerMESH™ IGBT

General features

Туре	V _{CES}	V _{CE(sat)} (Max)@ 25°C	Ι _C @100°C
STGB10NC60HD	600V	< 2.5V	10A
STGP10NC60HD	600V	< 2.5V	10A

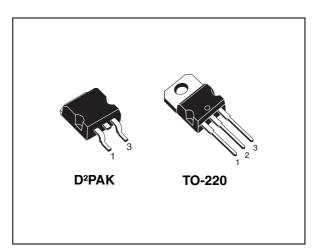
- Low on-voltage drop (V_{cesat})
- Low C_{RES} / C_{IES} ratio (no cross-conduction susceptibility)
- Very soft ultra fast recovery antiparallel diode

Description

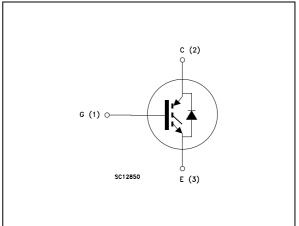
Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH[™] IGBTs, with outstanding performances. The suffix "H" identifies a family optimized for high frequency applications in order to achieve very high switching performances (reduced tfall) manta in ing a low voltage drop.

Applications

- High frequency motor controls
- Smps and pfc in both hard switch and resonant topologies
- Motor drivers



Internal schematic diagram



Order codes

Part Number	Marking	Package	Packaging
STGB10NC60HD	GB10NC60HD	D ² PAK	Tape & reel
STGP10NC60HD	GP10NC60HD	TO-220	Tube

1 Electrical ratings

Table 1.	Absolute	maximum	ratings
----------	----------	---------	---------

Symbol	Parameter	Value	Unit
V _{CES}	Collector-emitter voltage (V _{GS} = 0)	600	V
I _C ⁽¹⁾	Collector current (continuous) at $T_C = 25^{\circ}C$	20	A
I _C ⁽¹⁾	Collector current (continuous) at $T_C = 100^{\circ}C$	10	A
I _{CL} ⁽²⁾	Collector current (pulsed)	40	А
١ _F	Diode RMS forward current at $T_C = 25^{\circ}C$	10	A
V_{GE}	Gate-emitter voltage	±20	V
P _{TOT}	Total dissipation at $T_{C} = 25^{\circ}C$	60	W
T _{stg}	Storage temperature	- 55 to 150	
Тj	Operating junction temperature		°C

1. Calculated according to the iterative formula::

$$I_{C}(T_{C}) = \frac{T_{JMAX}^{-T}C}{R_{THJ-C} \times V_{CESAT(MAX)}^{-T}(T_{C}, I_{C})}$$

2. V_{clamp} =480V, Tj=150°C, R_G=10 Ω , V_{GE}=15V

Table 2. T	hermal	resistance
------------	--------	------------

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	2.08	°C/W
Rthj-amb	Thermal resistance junction-ambient max	62.5	°C/W

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{BR(CES)}	Collector-emitter breakdown voltage	I _C = 1mA, V _{GE} = 0	600			V
V _{CE(sat)}	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 5A V _{GE} = 15V, I _C = 5A, Tc= 125°C		1.9 1.7	2.5	V V
V _{GE(th)}	Gate threshold voltage	$V_{CE} = V_{GE}$, $I_C = 250 \ \mu A$	3.75		5.75	V
I _{CES}	Collector cut-off current (V _{GE} = 0)	V _{CE} = Max rating,T _C = 25°C V _{CE} =Max rating,T _C = 125°C			150 1	μA mA
I _{GES}	Gate-emitter leakage current (V _{CE} = 0)	V_{GE} = ±20V, V_{CE} = 0			±100	nA
9 _{fs}	Forward transconductance	$V_{CE} = 15V_{,} I_{C} = 5A$		3.5		S

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{ies} C _{oes} C _{res}	Input capacitance Output capacitance Reverse transfer capacitance	V _{CE} = 25V, f = 1MHz, V _{GE} = 0		365 43 8.3		pF pF pF
Q _g Q _{ge} Q _{gc}	Total gate charge Gate-emitter charge Gate-collector charge	$V_{CE} = 390$ V, $I_C = 5$ A, $V_{GE} = 15$ V, <i>(see Figure 17)</i>		19.2 4.5 7		nC nC nC

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V, Tj =$ $25^{\circ}C$ <i>(see Figure 16)</i>		14.2 5 1000		ns ns A/µs
t _{d(on)} t _r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V,$ $Tj=125^{\circ}C$ <i>(see Figure 16)</i>		14 5 920		ns ns A/µs
t _r (V _{off}) t _d (_{off}) t _f	Off voltage rise time Turn-off delay time Current fall time	$V_{cc} = 390V, I_{C} = 5A,$ $R_{GE} = 10\Omega, V_{GE} =$ $15V, T_{J} = 25^{\circ}C$ <i>(see Figure 16)</i>		27 72 85		ns ns ns
t _r (V _{off}) t _d (_{off}) t _f	Off voltage rise time Turn-off delay time Current fall time	$V_{cc} = 390$ V, $I_C = 5$ A, $R_{GE}=10\Omega$, $V_{GE} = 15$ V, Tj=125°C <i>(see Figure 16)</i>		50 108 139		ns ns ns

 Table 5.
 Switching on/off (inductive load)

Table 6. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
E _{on} ⁽¹⁾ E _{off} ⁽²⁾ E _{ts}	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V, I_C = 5A$ $R_G = 10\Omega, V_{GE} = 15V,$ $Tj = 25^{\circ}C$ <i>(see Figure 16)</i>		31.8 95 126.8		μJ μJ μJ
E _{on} ⁽¹⁾ E _{off} ⁽²⁾ E _{ts}	Turn-on switching losses Turn-off switching losses Total switching losses	$V_{CC} = 390V$, $I_C = 5A$ $R_G = 10\Omega$, $V_{GE} = 15V$, $Tj = 125^{\circ}C$ <i>(see Figure 16)</i>		61.8 173 234.8		μJ μJ μJ

 Eon is the tun-on losses when a typical diode is used in the test circuit in figure 2. If the IGBT is offered in a package with a co-pak diode, the co-pack diode is used as external diode. IGBTs & Diode are at the same temperature (25°C and 125°C)

2. Turn-off losses include also the tail of the collector current



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _f	Forward on-voltage	I _f = 2.5A I _f = 2.5A, Tj = 125°C		1.75 1.3	2.1	V V
t _{rr} Q _{rr} I _{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{f} = 5A, V_{R} = 40V,$ Tj = 25°C, di/dt = 100 A/µs (see Figure 19)		21.5 14.2 1.32		ns nC A
t _{rr} Q _{rr} I _{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _f = 5A,V _R = 40V, Tj =125°C, di/dt = 100A/μs <i>(see Figure 19)</i>		33 30.5 1.85		ns nC A

 Table 7.
 Collector-emitter diode



HV29575

Transfer characteristics

 $V_{CE} = 20V$

2.1 Electrical characteristics (curves)

Figure 1. Output characteristics

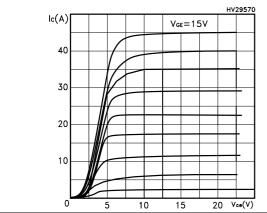


Figure 3. Transconductance

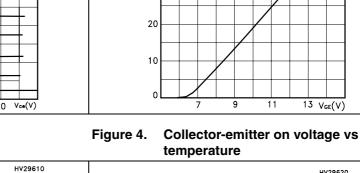


Figure 2.

lc(A)

40

30

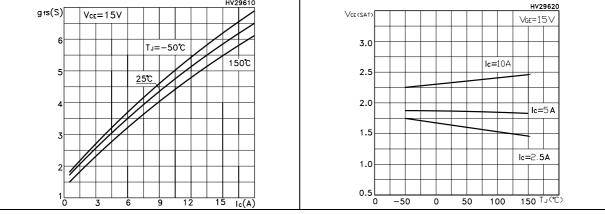
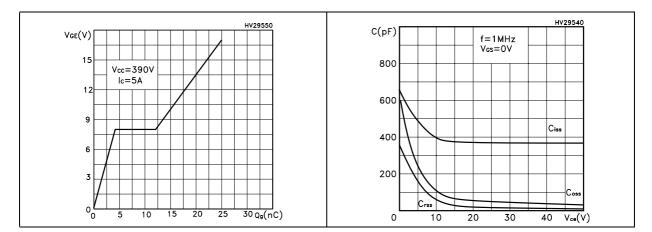


Figure 5. Gate charge vs gate-source voltage Figure 6. Capacitance variations



57

Figure 7. Normalized gate threshold voltage vs temperature

Figure 8. Collector-emitter on voltage vs collector current

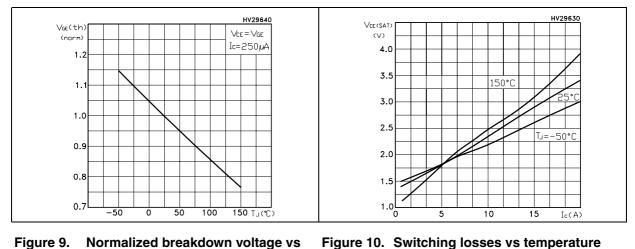


Figure 9. Normalized breakdown voltage vs temperature

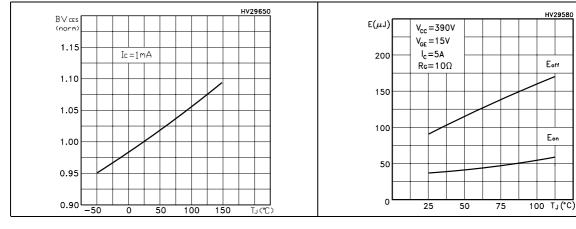


Figure 11. Switching losses vs gate resistance Figure 12. Switching losses vs collector current

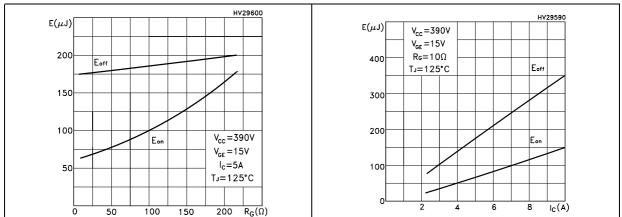
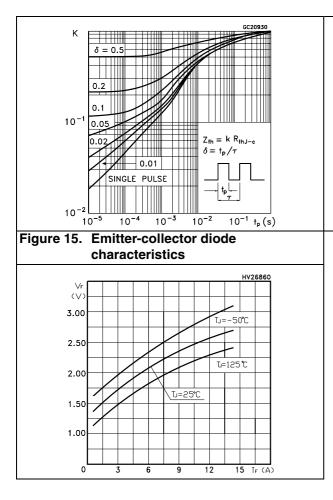
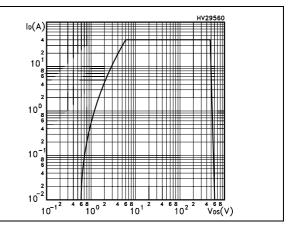


Figure 13. Thermal Impedance

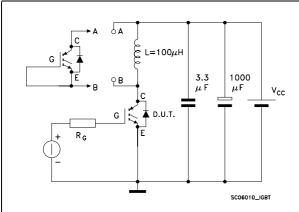
Figure 14. Turn-off SOA





57

Test circuit 3



switching

Figure 16. Test circuit for inductive load

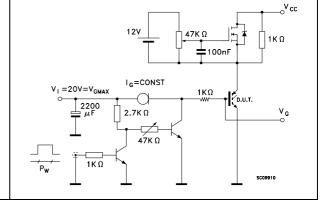
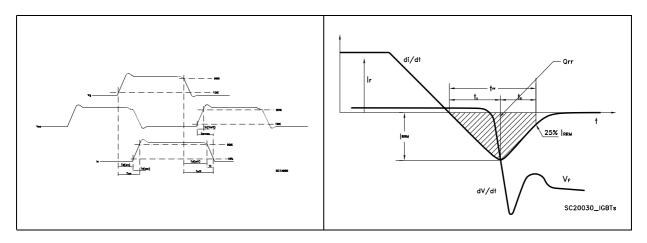


Figure 17. Gate charge test circuit

Figure 18. Switching waveform







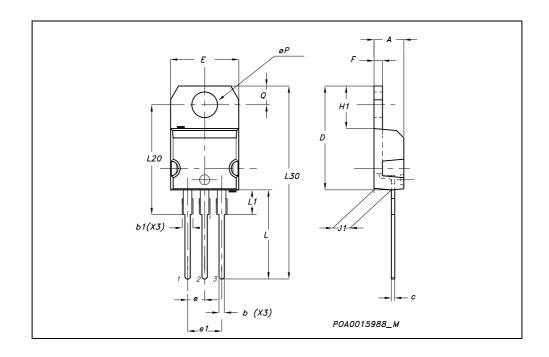
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com*



DIM.	mm.			inch		
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
С	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
Е	10		10.40	0.393		0.409
е	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øР	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116

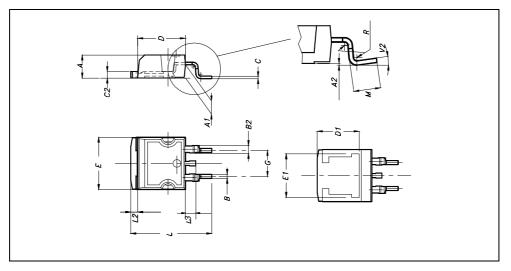




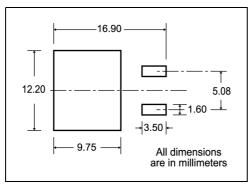
57

DIM	mm.			inch		
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
В	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
С	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
Е	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
М	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	0º		4º			

D²PAK MECHANICAL DATA

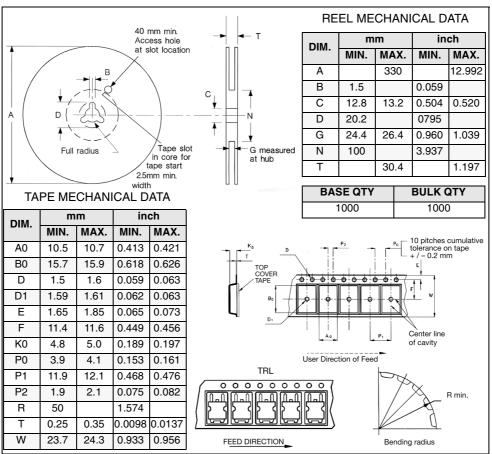


5 Packaging mechanical data



D²PAK FOOTPRINT

TAPE AND REEL SHIPMENT



* on sales type



6 Revision history

Date	Revision	Changes
30-Jan-2006	1	Initial release.
06-Nov-2006	2	Complete version
08-Feb-2007 3		The document has been reformatted



Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

UNLESS EXPRESSLY APPROVED IN WRITING BY AN AUTHORIZED ST REPRESENTATIVE, ST PRODUCTS ARE NOT RECOMMENDED, AUTHORIZED OR WARRANTED FOR USE IN MILITARY, AIR CRAFT, SPACE, LIFE SAVING, OR LIFE SUSTAINING APPLICATIONS, NOR IN PRODUCTS OR SYSTEMS WHERE FAILURE OR MALFUNCTION MAY RESULT IN PERSONAL INJURY, DEATH, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE. ST PRODUCTS WHICH ARE NOT SPECIFIED AS "AUTOMOTIVE GRADE" MAY ONLY BE USED IN AUTOMOTIVE APPLICATIONS AT USER'S OWN RISK.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2007 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan -Malaysia - Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

